PATTERN RECOGNITION

B.E., VII Semester, Electronics & Communication Engineering/ Telecommunication Engineering

[As per Choice Based Credit System (CBCS) scheme]

Subject Code	15EC753	IA Marks	20
Number of Lecture Hours/Week	03	Exam Marks	80
Total Number of Lecture Hours	40 (8 Hours / Module)	Exam Hours	03
CREDITS – 03			

Course Objectives: The objectives of this course are to:

- Introduce mathematical tools needed for Pattern Recognition
- Impart knowledge about the fundamentals of Pattern Recognition.
- Provide knowledge of recognition, decision making and statistical learning problems
- Introduce parametric and non-parametric techniques, supervised learning and clustering concepts of pattern recognition

Modules

Module-1	RBT Level
Introduction: Importance of pattern recognition, Features, Feature Vectors, and Classifiers, Supervised, Unsupervised, and Semi-supervised learning, Introduction to Bayes Decision Theory, Discriminant Functions and Decision Surfaces, Gaussian PDF and Bayesian Classification for Normal Distributions.	L1, L2
Module-2	
Data Transformation and Dimensionality Reduction: Introduction, Basis Vectors, The Karhunen Loeve (KL) Transformation, Singular Value Decomposition, Independent Component Analysis (Introduction only). Nonlinear Dimensionality Reduction, Kernel PCA.	L1, L2
Module-3	
Estimation of Unknown Probability Density Functions: Maximum Likelihood Parameter Estimation, Maximum a Posteriori Probability estimation, Bayesian Interference, Maximum Entropy Estimation, Mixture Models, Naive-Bayes Classifier, The Nearest Neighbor Rule.	L1, L2, L3
Module-4	
Linear Classifiers: Introduction, Linear Discriminant Functions and Decision Hyperplanes, The Perceptron Algorithm, Mean Square Error Estimate, Stochastic Approximation of LMS Algorithm, Sum of Error Estimate.	L1, L2, L3
Module-5	
Nonlinear Classifiers: The XOR Problem, The two Layer Perceptron, Three Layer Perceptron, Back propagation Algorithm, Basic Concepts of Clustering, Introduction to Clustering , Proximity Measures.	L1, L2, L3

Course outcomes: At the end of the course, students will be able to:

- Identify areas where Pattern Recognition and Machine Learning can offer a solution.
- Describe the strength and limitations of some techniques used in computational Machine Learning for classification, regression and density estimation problems
- Describe genetic algorithms, validation methods and sampling techniques
- Describe and model data to solve problems in regression and classification
- Implement learning algorithms for supervised tasks

Question paper pattern:

The question paper will have ten questions.

- Each full question consists of 16 marks.
- There will be 2 full questions (with a maximum of Three sub questions) from each module.
- Each full question will have sub questions covering all the topics under a module. The students will have to answer 5 full questions, selecting one full question from each module.

Text Book:

Pattern Recognition: Sergios Theodoridis, Konstantinos Koutroumbas, Elsevier India Pvt. Ltd (Paper Back), 4th edition.

Reference Books:

1. **The Elements of Statistical Learning:** Trevor Hastie, Springer-Verlag New York, LLC (Paper Back), 2009.
2. **Pattern Classification:** Richard O. Duda, Peter E. Hart, David G. Stork. John Wiley & Sons, 2012.
3. **Pattern Recognition and Image Analysis Earl Gose:** Richard Johnsonbaugh, Steve Jost, ePub eBook.

H. O. D.
Dept. Of Electronics & Communication
Alva's Institute of Engg. & Technology
Mijar, MOODBIDRI - 574 225